SIEMENS

600 V TRIAC DRIVER OPTOCOUPLER

FEATURES

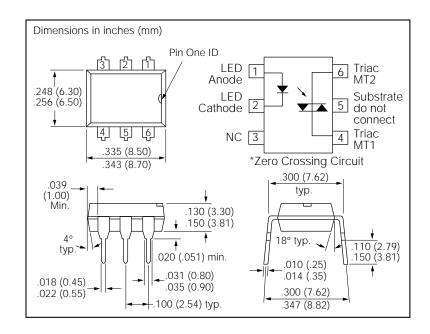
- High Input Sensitivity IFT=2 mA
- Blocking Voltage, 600 V
- 300 mA On-State Current
- High Static dv/dt 10,000 V/us
- Inverse Parallel SCRs Provide Commutating dv/dt >2K V/μs
- Very Low Leakage <10 μA
- Isolation Test Voltage from Double Molded Package 5300 VAC_{RMS}
- Small 6-Pin DIP Package
- Underwriters Lab File #E52744
- VDE 0884 Available with Option 1

Maximum Ratings

Emitter

Reverse Voltage Forward Current Surge Current Power Dissipation Derate from 25°C Thermal Resistance	60 mA 2.5 A 100 mW 1.33 mW/°C
Detector	
Peak Off-State Voltage Peak Reverse Voltage RMS On-State Current	600 V
Single Cycle Surge Total Power Dissipation	
Derate from 25°C	6.6 mW/°C
Package	
Storage Temperature	-55°C to +100°C

Isolation Test Voltage......5300 VAC_{RMS}



DESCRIPTION

The IL420 consists of a GaAs IRLED optically coupled to a photosensitive non-zero crossing TRIAC network. The TRIAC consists of two inverse parallel connected monolithic SCRs. These three semiconductors are assembled in a six pin 0.3 inch dual in-line package, using high insulation double molded, over/under leadframe construction.

High input sensitivity is achieved by using an emitter follower phototransistor and a cascaded SCR predriver resulting in an LED trigger current of less than 2 mA (DC).

The IL420 uses two discrete SCRs resulting in a commutating dV/dt of greater than 10KV/ms. The use of a proprietary *dv/dt clamp* results in a static dV/dt of greater than 10KV/ms. This clamp circuit has a MOSFET that is enhanced when high dV/dt spikes occur between MT1 and MT2 of the TRIAC. When conducting, the FET clamps the base of the phototransistor, disabling the first stage SCR predriver.

The 600 V blocking voltage permits control of off-line voltages up to 240 VAC, with a safety factor of more than two, and is sufficient for as much as 380 VAC.

The IL420 isolates low-voltage logic from 120, 240, and 380 VAC lines to control resistive, inductive, or capacitive loads including motors, solenoids, high current thyristors or TRIAC and relays.

Applications include solid-state relays, industrial controls, office equipment, and consumer appliances.

Characteristics

	Symbol	Min	Тур	Max	Unit	Condition
Emitter		'				
Forward Voltage	V _F		1.16	1.35	V	I _F =10 mA
Reverse Current	I _R		0.1	10	μΑ	V _R =6 V
Capacitance	Co		40		pF	V _F =0 V, f=1 MHz
Thermal Resistance, Junction to Lead	R _{THJL}		750		°C/W	
Output Detector						
Off-State Voltage	V _{D (RMS)}	424	460		V	I _{D(RMS)} =70 μA
Reverse Voltage	V _R	424	460		V	I _{R(RMS)} =70 μA
Off-State Current	I _{D (RMS)}		10	100	μΑ	V _D =600 V, T _A =100°C
Reverse Current	I _{R (RMS)}		10	100	μА	V _R =600 V, T _A =100°C
On-State Voltage	V _{TM}		1.7	3	V	I _T =300 mA
On-State Current	I _{TM}			300	mA	PF=1.0, V _{T(RMS)} =1.7 V
Surge (Non-Repititive) On-State Current	I _{TSM}			3	А	f=50 Hz
Holding Current	I _H		65	500	μΑ	
Latching Current	IL		5		mA	V _T =2.2 V
LED Trigger Current	I _{FT}		1	2	mA	V _{AK} =5 V
Turn-On Time	t _{ON}		35		μs	V _{RM} =V _{DM} =424 VAC
Turn-Off Time	t _{OFF}		50		μs	PF=1.0, I _T =300 mA
Critical State of Rise of Off-State Voltage	dv/dt _{cr} dv/dt _{cr}	10000 5000			V/µs V/µs	V _D =0.67 V _{DRM} T _j =25°C Tj=80°C
Critical Rate of Rise of Voltage at Current Commutation	dv/dt _{crq} dv/dt _{crq}	10000 5000			V/μs V/μs	V_D =0.67 V_{DRM} , di/dt _{crq} \leq 15 A/ms T_j =25°C T_j =80°C
Critical State of Rise of On-State Current	di/dt _{cr}			8	A/µs	
Thermal Resistance, Junction to Lead	R _{THJL}		150		°C/W	
Insulation and Isolation	<u> </u>					
Critical Rate of Rise of Coupled Input/Output Voltage	dv _(IO) /dt		5000		V/µs	I _T =0 A, V _{RM} =V _{DM} =424 VAC
Common Mode Coupling Capacitor	C _{CM}		0.01		pF	
Package Capacitance	C _{IO}		0.8		pF	f=1 MHz, V _{IO} =0 V
Isolation Test Voltage, Input-Output	V _{ISO}	5300			VAC _{RMS}	Relative Humidity ≤50%
Creepage		≥7			mm	
Clearance		≥7			mm	
Creepage Tracking Resistance per DIN IEC 112/VDE 0303, Part 1 group IIIa per DIN VDE 0110		СТІ		175		
Isolation Resistance	R _{is} R _{is}		≥10 ¹² ≥10 ¹¹		ΩΩ	V _{IO} =500, T _A =25°C V _{IO} =500, T _A =100°C
Trigger Current Temperature Gradient	$\Delta I_{FT}/\Delta T_{j}$		7	14	μΑ/Κ	
Capacitance Between Input and Output Circuit	C _{IO}			2	pF	V _R =0, f=1 kHz

IL420

Figure 1. Forward voltage versus forward current

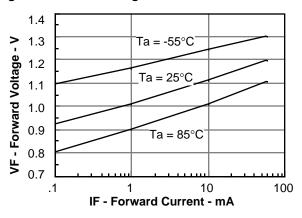


Figure 2. Peak LED current versus duty factor, Tau

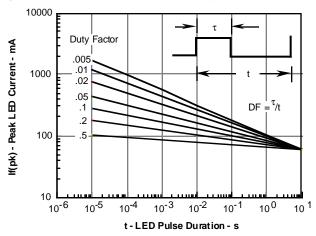


Figure 3. Maximum LED power dissipation

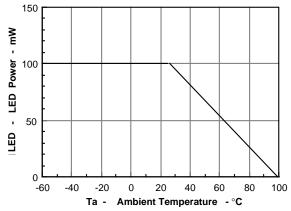


Figure 4. Typical output characteristics

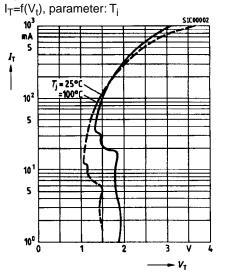


Figure 5. Current reduction

 I_{TRMS} =f(T_A) R_{thJA} =125 K/W Device switch is soldered in PCB or base plate

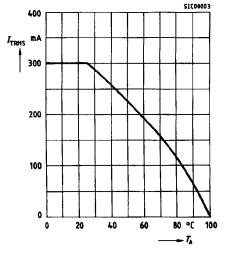


Figure 6. Current reduction

I_{TRMS}=f(T_{PIN5}), R_{thJ}=16.5 K/W Thermocouple measurement must be performed potentially separated to A1 and A2. Measuring junction to be as near as possible at case.

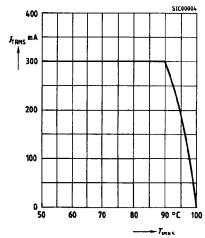


Figure 7. Typical trigger delay time

 $tgd=f(I_F/I_{FT25^{\circ}C})$, $V_D=200$ V, parameter: T_i

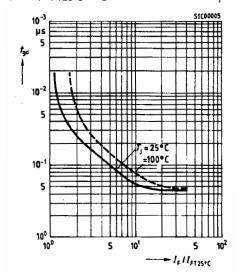


Figure 8. Typical off-state current $I_D=f(T_j)$, $V_D=800$ V, parameter: T_j

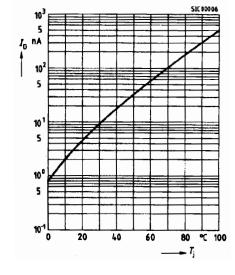


Figure 9. Power dissipation

for 40 to 60 Hz line operation, P_{TOT}=f(I_{TRMS})

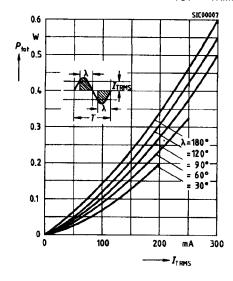


Figure 10. Pulse trigger current

 I_{FTN} =f(t_{pIF}) I_{FTN} normalized to I_{FT} , referring to t_{pIF} \geq 1ms, V_{OP} =200 V, f=40 to 60 Hz typ.

